

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination NAWATA ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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	N	JP 2000272990 A	10-2000	Japan	TOMITA et al.	---
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